Se	earcn Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	***************************************
10/722,465	KIM ET AL.	
Examiner	Art Unit	
Rita R Patel	1746	

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Class	Subclass	Date	Examiner
68	17R, 17A, 23A, 5E	9/13/2006	RRP
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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Inventor search.	9/13/2006	RRP
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EAST key word search.	9/13/2006	RRP
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